

**Notice of References Cited**

Application/Control No.

10/510,372

Applicant(s)/Patent Under  
Reexamination  
STRAUB ET AL.

Examiner

IZUNNA OKEKE

Art Unit

2432

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,371,794 A	12-1994	Diffie et al.	713/156
*	B	US-2002/0045442 A1	04-2002	Silen et al.	455/420
*	C	US-6,956,461 B2	10-2005	Yoon et al.	340/310.11
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.